



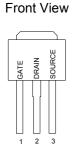
GENERAL DESCRIPTION

This high voltage MOSFET uses an advanced termination scheme to provide enhanced voltage-blocking capability without degrading performance over time. In addition, this advanced MOSFET is designed to withstand high energy in avalanche and commutation modes. The new energy efficient design also offers a drain-to-source diode with a fast recovery time. Designed for high voltage, high speed switching applications in power supplies, converters and PWM motor controls, these devices are particularly well suited for bridge circuits where diode speed and commutating safe operating areas are critical and offer additional and safety margin against unexpected voltage transients.

FEATURES

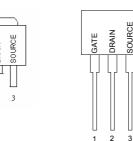
- Robust High Voltage Termination
- Avalanche Energy Specified
- Source-to-Drain Diode Recovery Time Comparable to a Discrete Fast Recovery Diode
- Diode is Characterized for Use in Bridge Circuits
- I_{DSS} and V_{DS}(on) Specified at Elevated Temperature

PIN CONFIGURATION



TO-251

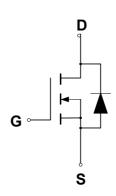




TO-92

Front View

SYMBOL



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS

| Rating | Symbol | Value | Unit |
|--|-----------------------------------|------------|------------------------|
| Drain to Current — TO-251(Continuous) | I_D | 0.9 | |
| TO-92 (Continuous) | | 0.29 | Α |
| Pulsed (TO-251) | I_{DM} | 2.7 | |
| Gate-to-Source Voltage — Continue | V_{GS} | ±30 | V |
| Total Power Dissipation TO-251 | | 31 | W |
| TO-92 | P_D | 2.9 | |
| Derate above 25℃ TO-251 | | 0.23 | W/°C |
| TO-92 | | 0.02 | |
| Operating and Storage Temperature Range | T _J , T _{STG} | -55 to 150 | °C |
| Single Pulse Drain-to-Source Avalanche Energy $-T_J = 25^{\circ}$ C ($V_{DD} = 100V$, $V_{GS} = 10V$, $I_{AS} = 0.7A$, $L = 50mH$, $R_G = 25\Omega$) | E _{AS} | 2.45 | mJ |
| Thermal Resistance — Junction to Case (TO-251) | θ _{JC} | 4.5 | °C/W |
| Junction to Lead (TO-92) | θ_{JL} | 48 | |
| Junction to Ambient (TO-251) | θ_{JA} | 120 | |
| Junction to Ambient (TO-92) | | 140 | |
| Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds | TL | 260 | $^{\circ}\!\mathbb{C}$ |

Power Field Effect Transistor





ORDERING INFORMATION

| Part Number | Package |
|----------------|---------|
| GPT01N65AGN251 | TO-251 |
| GPT01N65AGN252 | TO-252 |
| GPT01N65AGN92 | TO-92 |

*Note: G: Suffix for Pb Free Product

ELECTRICAL CHARACTERISTICS

Unless otherwise specified, $T_J = 25^{\circ}C$.

| | | | | GPT01N65 | A | |
|--|--|---------------------|-----|----------|-----|-------|
| Cha | racteristic | Symbol | Min | Тур | Max | Units |
| Drain-Source Breakdown Voltage | | V | 650 | | | V |
| $(V_{GS} = 0 \text{ V}, I_D = 250 \ \mu \text{ A})$ | | $V_{(BR)DSS}$ | 000 | | | V |
| Drain-Source Leakage Current | | | | | | |
| $(V_{DS} = 650 \text{ V}, V_{GS} = 0 \text{ V}, \text{TO-92})$ | 2) | I _{DSS} | | | 50 | uA |
| (V _{DS} = 650 V, V _{GS} = 0 V, TO-251) | | | | | 1 | |
| Gate-Source Leakage Current-Fo | orward | | | | 100 | nA |
| $(V_{gsf} = 30 \text{ V}, V_{DS} = 0 \text{ V})$ | | I _{GSSF} | | | 100 | IIA |
| Gate-Source Leakage Current-Reverse | | I _{GSSR} | | | 100 | nA |
| | $(V_{gsr} = -30 \text{ V}, V_{DS} = 0 \text{ V})$ | | | | | |
| Gate Threshold Voltage | | $V_{GS(th)}$ | 2.5 | 3.5 | 4.5 | V |
| $(V_{DS} = V_{GS}, I_D = 250 \ \mu A)$ | | - 63(11) | | 0.0 | 1.0 | • |
| Static Drain-Source On-Resistance (V_{GS} = 10 V, I_D = 0.5A) * | | | | | | |
| TO-251 | | R _{DS(on)} | | | 13 | Ω |
| TO-92 | | | | | | |
| Forward Transconductance (V _{DS} | \geq 50 V, I _D = 0.5A) * | g FS | | 1.3 | | S |
| Input Capacitance | $(V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ | C _{iss} | | 161.1 | | pF |
| Output Capacitance | f = 1.0 MHz | Coss | | 14.1 | | pF |
| Reverse Transfer Capacitance | 1 = 1.0 IVIN2) | C _{rss} | | 1.03 | | pF |
| Turn-On Delay Time | | $t_{d(on)}$ | | 11.3 | | ns |
| Rise Time | $(V_{DD} = 325 \text{ V}, I_D = 0.5 \text{ A},$ | t _r | | 30.1 | | ns |
| Turn-Off Delay Time | $R_G = 25\Omega)$ * | $t_{d(off)}$ | | 34.1 | | ns |
| Fall Time | | t _f | | 65.1 | | ns |
| Total Gate Charge | $(V_{DS} = 520 \text{ V}, I_{D} = 0.5 \text{ A},$ $V_{GS} = 10 \text{ V})^*$ | Q_g | | 6.15 | | nC |
| Gate-Source Charge | | Q_gs | | 1.12 | | nC |
| Gate-Drain Charge | , | Q_{gd} | | 3.67 | | nC |
| SOURCE-DRAIN DIODE CHARA | ACTERISTICS | | | | | |
| Forward On-Voltage(1) | $(I_S = 0.5 \text{ A}, V_{GS} = 0 \text{ V}, \\ d_{IS}/d_t = 100\text{A/}\mu\text{s})$ | V _{SD} | | | 1.4 | V |
| Forward Turn-On Time | | t _{on} | | ** | | ns |
| Reverse Recovery Time | α _S /α _t = 100/ν μ3) | t _{rr} | | 180 | | ns |

^{*} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%

^{**} Negligible, Dominated by circuit inductance





TYPICAL ELECTRICAL CHARACTERISTICS

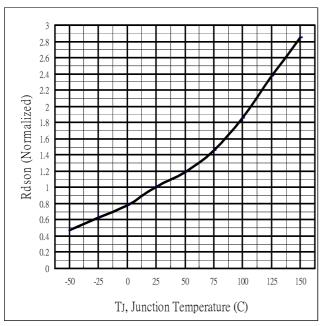
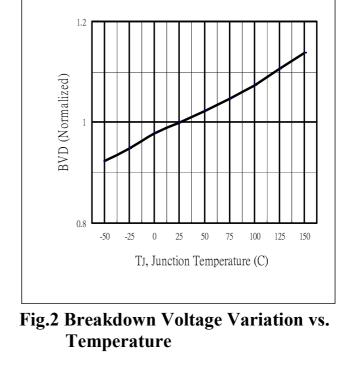


Fig 1. On-Resistance Variation with vs. Temperature



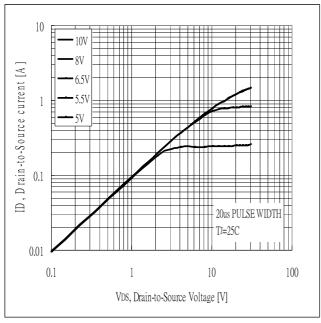


Fig 3. Typical Output Characteristics

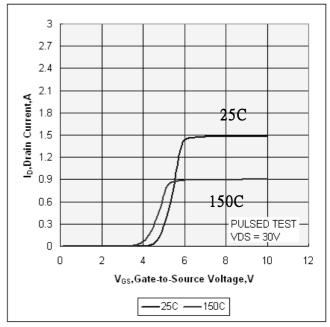


Fig 4. Typical Transfer Characteristics





GPT01N65A

Power Field Effect Transistor

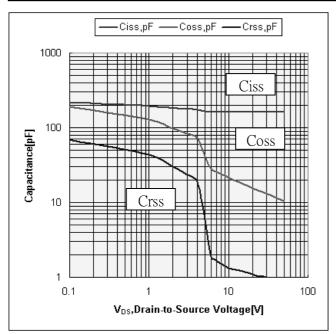


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

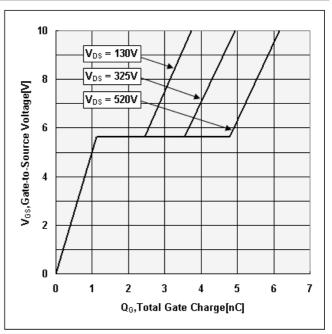


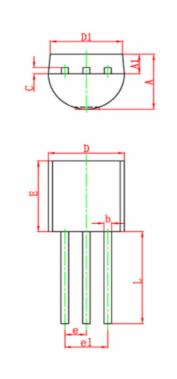
Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage





PACKAGE DIMENSION



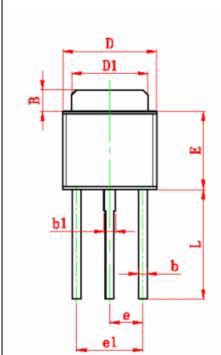


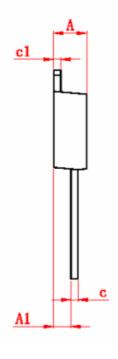
| Symbol | Dimensions In Millimeters | | |
|--------|---------------------------|------|--|
| | Min. | Max | |
| Α | 3.25 | 3.85 | |
| A1 | 1.00 | 1.50 | |
| b | 0.38 | 0.58 | |
| С | 0.30 | 0.52 | |
| D | 4.30 | 4.90 | |
| D1 | 4.00 TYP. | | |
| E | 4.20 | 4.80 | |
| е | 1.27 TYP. | | |
| e1 | 2.40 | 2.70 | |

13.00

15.00

TO-92





TO251

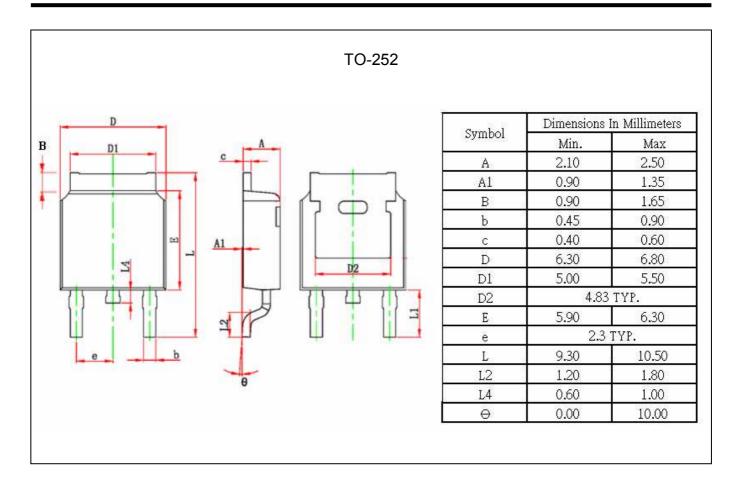
| Symbol | Dimensions In Millimeters | | |
|--------|---------------------------|------|--|
| | Min. | Max | |
| Α | 2.10 | 2.50 | |
| A1 | 0.90 | 1.35 | |
| В | 0.90 | 1.65 | |
| b | 0.45 | 0.75 | |
| b1 | 0.65 | 0.95 | |
| С | 0.40 | 0.60 | |
| c1 | 0.40 | 0.60 | |
| D | 6.30 | 6.80 | |
| D1 | 5.00 | 5.50 | |
| E | 5.40 | 6.30 | |
| е | 2.3 TYP. | | |
| e1 | 4.40 | 4.80 | |
| L | 7.40 | 8.00 | |





GPT01N65A

Power Field Effect Transistor





GPT01N65A

POWER FIELD EFFECT TRANSISTOR

IMPORTANT NOTICE

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深圳

新北市汐止區新台五路一段 96 號 21F

21F., No. 96, Sec. 1, Sintai 5th Rd., Sijhih City, Taipei County 22102,

Taiwan, R.O.C.

TEL: +886-2-2696 3558 FAX: +886-2-2696 3559 深圳市福田区深南大道 7002 号财富广场 A座 4V,

4V, Tower A, Fortune Plaza, No. 7002, Shennan Road, Futian District, Shenzhen City, China

PC : 518040

TEL: +86-755-83709176 FAX: +86-755-83709276